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Chipsmall Limited consists of a professional team with an average of over 10 year of expertise in the distribution of electronic components. Based in Hongkong, we have already established firm and mutual-benefit business relationships with customers from,Europe,America and south Asia,supplying obsolete and hard-to-find components to meet their specific needs.

With the principle of "Quality Parts,Customers Priority,Honest Operation, and Considerate Service",our business mainly focus on the distribution of electronic components. Line cards we deal with include Microchip,ALPS,ROHM,Xilinx,Pulse,ON,Everlight and Freescale. Main products comprise IC,Modules,Potentiometer,IC Socket,Relay,Connector.Our parts cover such applications as commercial,industrial, and automotives areas.

We are looking forward to setting up business relationship with you and hope to provide you with the best service and solution. Let us make a better world for our industry!


## Contact us

Tel: +86-755-8981 8866 Fax: +86-755-8427 6832
Email \& Skype: info@chipsmall.com Web: www.chipsmall.com Address: A1208, Overseas Decoration Building, \#122 Zhenhua RD., Futian, Shenzhen, China

Preliminary Technical Information

## Depletion Mode MOSFET

$V_{\mathrm{DSX}}=1700 \mathrm{~V}$
$\mathrm{I}_{\mathrm{D}(\text { on })} \geq 1 \mathrm{~A}$
$\mathrm{R}_{\mathrm{DS}(\text { (n) })} \leq 16 \Omega$

## N -Channel



| Symbol | Test Conditions | Maximum Ratings |  |
| :---: | :---: | :---: | :---: |
| $\mathrm{V}_{\text {DSX }}$ | $\mathrm{T}_{J}=25^{\circ} \mathrm{C}$ to $150^{\circ} \mathrm{C}$ | 1700 | V |
| $\mathrm{V}_{\text {DGX }}$ | $\mathrm{T}_{\mathrm{J}}=25^{\circ} \mathrm{C}$ to $150^{\circ} \mathrm{C}, \mathrm{R}_{\mathrm{GS}}=1 \mathrm{M} \Omega$ | 1700 | V |
| $\mathrm{V}_{\text {GSX }}$ | Continuous | $\pm 20$ | V |
| $\mathrm{V}_{\text {GSM }}$ | Transient | $\pm 30$ | V |
| $\mathrm{P}_{\mathrm{D}}$ | $\mathrm{T}_{\mathrm{C}}=25^{\circ} \mathrm{C}$ | 290 | W |
| $\mathrm{T}_{\mathrm{J}}$ |  | - $55 \ldots+150$ | ${ }^{\circ} \mathrm{C}$ |
| $\mathrm{T}_{\text {JM }}$ |  | 150 | ${ }^{\circ} \mathrm{C}$ |
| $\mathrm{T}_{\text {stg }}$ |  | - $55 \ldots+150$ | ${ }^{\circ} \mathrm{C}$ |
| $\mathrm{T}_{\mathrm{L}}$ | Maximum Lead Temperature for Soldering | 300 | ${ }^{\circ} \mathrm{C}$ |
| $\mathrm{T}_{\text {SoLD }}$ | 1.6 mm (0.062in.) from Case for 10s | 260 | ${ }^{\circ} \mathrm{C}$ |
| $\mathrm{F}_{\mathrm{c}}$ | Mounting Force (TO-263HV) | 10.. 65 / 22.. 14.6 | N/lb |
| $\mathrm{M}_{\mathrm{d}}$ | Mounting Torque (TO-247HV) | 1.13/10 | Nm/lb.in |
| Weight | TO-263HV | 2.5 | g |
|  | TO-247HV | 6.0 | g |



G = Gate $\quad \mathrm{D} \quad$ = Drain
$S=$ Source $\quad T a b=$ Drain

## Features

- Normally ON Mode
- Molding Epoxies Meet UL94V-0 Flammability Classification


## Advantages

- Easy to Mount
- Space Savings
- High Power Density


## Applications

- Audio Amplifiers
- Start-Up Circuits
- Protection Circuits
- Ramp Generators
- Current Regulators
- Active Loads



## Safe-Operating-Area Specification

|  |  | Characteristic Values |  |  |
| :--- | :--- | :--- | :--- | :--- |
| Symbol | Test Conditions | Min. | Typ. | Max. |
| SOA | $\mathrm{V}_{\mathrm{DS}}=1700 \mathrm{~V}, \mathrm{I}_{\mathrm{D}}=100 \mathrm{~mA}, \mathrm{~T}_{\mathrm{C}}=75^{\circ} \mathrm{C}, \mathrm{Tp}=5 \mathrm{~s}$ | 170 |  |  |

Source-Drain Diode


Note 1. Pulse test, $\mathrm{t} \leq 300 \mu \mathrm{~s}$, duty cycle, $\mathrm{d} \leq 2 \%$.

## PRELIMANARY TECHNICAL INFORMATION

The product presented herein is under development. The Technical Specifications offered are derived from a subjective evaluation of the design, based upon prior knowledge and experience, and constitute a "considered reflection" of the anticipated result. IXYS reserves the right to change limits, test conditions, and dimensions without notice.

IXYS Reserves the Right to Change Limits, Test Conditions, and Dimensions.

| IXYS MOSFETs and IGBTs are covered | 4,835,592 | 4,931,844 | 5,049,961 | 5,237,481 | 6,162,665 | 6,404,065 B1 | 6,683,344 | 6,727,585 | 7,005,734 B2 | 7,157,338B2 |
| :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: |
| by one or more of the following U.S. patents: | 4,860,072 | 5,017,508 | 5,063,307 | 5,381,025 | 6,259,123 B1 | 6,534,343 | 6,710,405 B2 | 6,759,692 | 7,063,975 B2 |  |
|  | 4,881,106 | 5,034,796 | 5,187,117 | 5,486,715 | 6,306,728 B1 | 6,583,505 | 6,710,463 | 6,771,478 | 7,071,537 |  |

Fig. 1. Output Characteristics @ $\mathrm{T}_{\mathrm{J}}=\mathbf{2 5}^{\circ} \mathrm{C}$


Fig. 3. Output Characteristics @ $\mathrm{T}_{\mathrm{J}}=125^{\circ} \mathrm{C}$


Fig. 5. Drain Current $@ \mathrm{~T}_{\mathrm{J}}=100^{\circ} \mathrm{C}$


Fig. 2. Extended Output Characteristics @ $\mathbf{T}_{\mathbf{J}}=\mathbf{2 5}^{\mathbf{\circ}} \mathrm{C}$


Fig. 4. Drain Current @ $\mathrm{T}_{\mathrm{J}}=25^{\circ} \mathrm{C}$


Fig. 6. Dynamic Resistance vs. Gate Voltage


Fig. 7. Normalized $\mathrm{R}_{\mathrm{DS}(o n)}$ vs. Junction Temperature


Fig. 9. Input Admittance


Fig. 11. Normalized Breakdown and Threshold
Voltages vs. Junction Temperature


Fig. 8. R $\mathrm{RSS}_{\mathrm{D}(\text { on) }}$ Normalized to $\mathrm{I}_{\mathrm{D}}=0.5 \mathrm{~A}$ Value vs. Drain Current


Fig. 10. Transconductance


Fig. 12. Forward Voltage Drop of Intrinsic Diode


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Fig. 13. Capacitance


Fig. 15. Forward-Bias Safe Operating Area


Fig. 14. Gate Charge


Fig. 16. Forward-Bias Safe Operating Area


Fig. 17. Maximum Transient Thermal Impedance


